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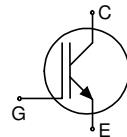
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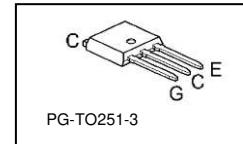
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Low Loss IGBT : IGBT in TRENCHSTOP™ technology



- Very low  $V_{CE(sat)}$  1.5 V (typ.)
- Maximum Junction Temperature 175°C
- Short circuit withstand time 5μs
- Designed for :
  - frequency inverters
  - drives
- TRENCHSTOP™ technology for 600V applications offers :
  - very tight parameter distribution
  - high ruggedness, temperature stable behavior
  - very high switching speed
  - low  $V_{CE(sat)}$
- Positive temperature coefficient in  $V_{CE(sat)}$
- Low EMI
- Low Gate Charge
- Qualified according to JEDEC<sup>1</sup> for target applications
- Complete product spectrum and PSpice Models : <http://www.infineon.com/igbt/>



| Type      | $V_{CE}$ | $I_c$ | $V_{CE(sat), T_j=25^\circ C}$ | $T_{j,max}$ | Marking | Package    |
|-----------|----------|-------|-------------------------------|-------------|---------|------------|
| IGU04N60T | 600 V    | 4 A   | 1.5 V                         | 175 °C      | G04T60  | PG-T0251-3 |

### Maximum Ratings

| Parameter  | Symbol    | Value      | Unit |
|--|-----------|------------|------|
| Collector-emitter voltage  | $V_{CE}$  | 600        | V    |
| DC collector current, limited by $T_{j,max}$<br>$T_C = 25^\circ C$<br>$T_C = 100^\circ C$                  | $I_c$     | 9.5        | A    |
| Pulsed collector current, $t_p$ limited by $T_{j,max}$   |           | 6.5        |      |
| Turn off safe operating area ( $V_{CE} \leq 600V$ , $T_j \leq 175^\circ C$ )                               | -         | 12         |      |
| Gate-emitter voltage   | $V_{GE}$  | $\pm 20$   | V    |
| Short circuit withstand time <sup>2)</sup><br>$V_{GE} = 15V$ , $V_{CC} \leq 400V$ , $T_j \leq 150^\circ C$ | $t_{sc}$  | 5          | μs   |
| Power dissipation $T_C = 25^\circ C$   | $P_{tot}$ | 42         | W    |
| Operating junction temperature   | $T_j$     | -40...+175 | °C   |
| Storage temperature  | $T_{stg}$ | -55...+150 |      |
| Soldering temperature,<br>wave soldering, 1.6mm (0.063 in.) from case for 10s.                             | $T_s$     | 260        | °C   |

<sup>1</sup> J-STD-020 and JESD-022

<sup>2</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.

**Thermal Resistance**

| Parameter                                   | Symbol     | Conditions | Max. Value | Unit |
|---|------------|------------|------------|------|
| <b>Characteristic</b>                       |            |            |            |      |
| IGBT thermal resistance,<br>junction – case | $R_{thJC}$ |            | 3.5        | K/W  |
| Thermal resistance,<br>junction – ambient   | $R_{thJA}$ |            | 75         |      |

**Electrical Characteristic**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                            | Symbol               | Conditions                                  | Value |      |      | Unit          |
|--------------------------------------|----------------------|---|-------|------|------|---------------|
|                                      |                      |   | min.  | Typ. | max. |               |
| <b>Static Characteristic</b>         |                      |   |       |      |      |               |
| Collector-emitter breakdown voltage  | $V_{(BR)CES}$        | $V_{GE}=0\text{V}, I_C=0.2\text{mA}$        | 600   | -    | -    | V             |
| Collector-emitter saturation voltage | $V_{CE(\text{sat})}$ | $V_{GE} = 15\text{V}, I_C=4\text{A}$        | -     | 1.5  | 2.05 |               |
|                                      |                      | $T_j=25^\circ\text{C}$                      | -     | 1.9  | -    |               |
| Gate-emitter threshold voltage       | $V_{GE(\text{th})}$  | $I_C = 60\mu\text{A}, V_{CE}=V_{GE}$        | 4.1   | 4.9  | 5.7  |               |
|                                      |                      |   | -     | -    | -    |               |
| Zero gate voltage collector current  | $I_{CES}$            | $V_{CE}=600\text{V},$<br>$V_{GE}=0\text{V}$ | -     | -    | 40   | $\mu\text{A}$ |
|                                      |                      | $T_j=25^\circ\text{C}$                      | -     | 40   | -    |               |
| Gate-emitter leakage current         | $I_{GES}$            | $V_{CE}=0\text{V}, V_{GE}=20\text{V}$       | -     | -    | 100  | nA            |
|                                      |                      |   | -     | -    | -    |               |
| Transconductance                     | $g_{fs}$             | $V_{CE}=20\text{V}, I_C=4\text{A}$          | -     | 2.2  | -    | S             |

**Dynamic Characteristic**

|   |                   |  |   |     |   |    |
|---|-------------------|--|---|-----|---|----|
| Input capacitance   | $C_{iss}$         | $V_{CE}=25\text{V},$                         | - | 252 | - | pF |
| Output capacitance  | $C_{oss}$         | $V_{GE}=0\text{V},$                          |   | 20  | - |    |
| Reverse transfer capacitance                                      | $C_{rss}$         | $f=1\text{MHz}$                              |   | 7.5 | - |    |
| Gate charge   | $Q_{\text{Gate}}$ | $V_{CC}=480\text{V}, I_C=4\text{A}$          | - | 27  | - | nC |
| Internal emitter inductance<br>measured 5mm (0.197 in.) from case | $L_E$             |  | - | 7   | - | nH |
| Short circuit collector current <sup>1)</sup>                     | $I_{C(SC)}$       | $V_{GE}=15\text{V}, t_{SC}\leq 5\mu\text{s}$ | - | 36  | - | A  |
|   |                   | $V_{CC} = 400\text{V},$                      |   |     |   |    |
|   |                   | $T_j \leq 150^\circ\text{C}$                 |   |     |   |    |

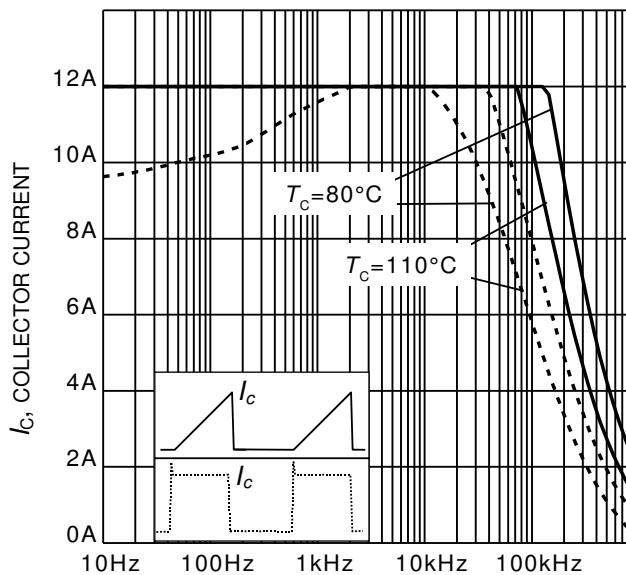
<sup>1)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.

**Switching Characteristic, Inductive Load, at  $T_j=25\text{ °C}$** 

| Parameter                  | Symbol       | Conditions  | Value |      |      | Unit          |
|----------------------------|--------------|---|-------|------|------|---------------|
|                            |              |   | min.  | Typ. | max. |               |
| <b>IGBT Characteristic</b> |              |   |       |      |      |               |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=25\text{ °C}$ ,<br>$V_{CC}=400\text{V}$ , $I_C=4\text{A}$ ,<br>$V_{GE}=0/15\text{V}$ ,           | -     | 14   | -    | ns            |
| Rise time                  | $t_r$        | $r_G=47\Omega$ , $L_\sigma=150\text{nH}$ ,<br>$C_\sigma=47\text{pF}$                                  | -     | 7    | -    |               |
| Turn-off delay time        | $t_{d(off)}$ | $L_\sigma$ , $C_\sigma$ from Fig. E<br>Energy losses include<br>“tail” and diode reverse<br>recovery. | -     | 164  | -    |               |
| Fall time                  | $t_f$        |   | -     | 43   | -    |               |
| Turn-on energy             | $E_{on}$     |   | -     | 61   | -    | $\mu\text{J}$ |
| Turn-off energy            | $E_{off}$    |   | -     | 84   | -    |               |
| Total switching energy     | $E_{ts}$     |   | -     | 145  | -    |               |

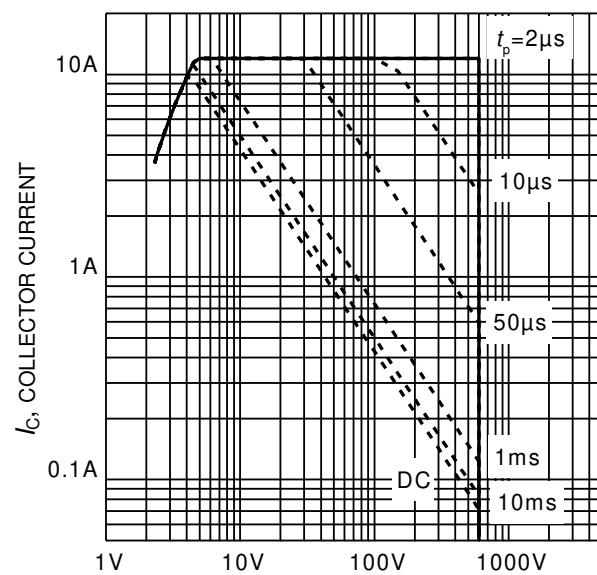
**Switching Characteristic, Inductive Load, at  $T_j=175\text{ °C}$** 

| Parameter                  | Symbol       | Conditions  | Value |      |      | Unit          |
|----------------------------|--------------|---|-------|------|------|---------------|
|                            |              |   | min.  | Typ. | max. |               |
| <b>IGBT Characteristic</b> |              |   |       |      |      |               |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=175\text{ °C}$ ,<br>$V_{CC}=400\text{V}$ , $I_C=4\text{A}$ ,<br>$V_{GE}=0/15\text{V}$ ,          | -     | 14   | -    | ns            |
| Rise time                  | $t_r$        | $r_G=47\Omega$ , $L_\sigma=150\text{nH}$ ,<br>$C_\sigma=47\text{pF}$                                  | -     | 10   | -    |               |
| Turn-off delay time        | $t_{d(off)}$ | $L_\sigma$ , $C_\sigma$ from Fig. E<br>Energy losses include<br>“tail” and diode reverse<br>recovery. | -     | 185  | -    |               |
| Fall time                  | $t_f$        |   | -     | 83   | -    |               |
| Turn-on energy             | $E_{on}$     |   | -     | 99   | -    | $\mu\text{J}$ |
| Turn-off energy            | $E_{off}$    |   | -     | 97   | -    |               |
| Total switching energy     | $E_{ts}$     |   | -     | 196  | -    |               |



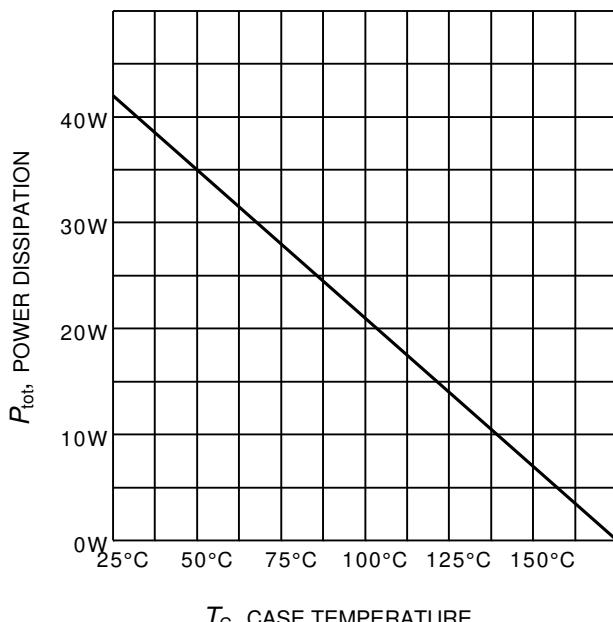
**Figure 1. Collector current as a function of switching frequency**

( $T_j \leq 175^\circ\text{C}$ ,  $D = 0.5$ ,  $V_{\text{CE}} = 400\text{V}$ ,  
 $V_{\text{GE}} = 0/15\text{V}$ ,  $r_G = 47\Omega$ )

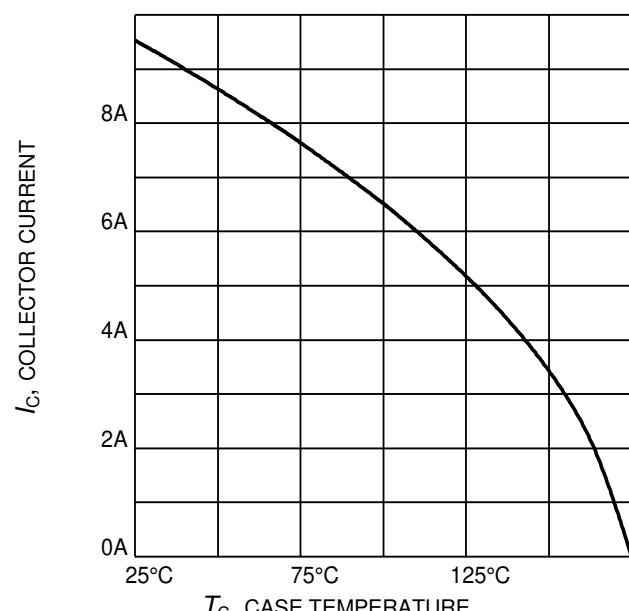


**Figure 2. Safe operating area**

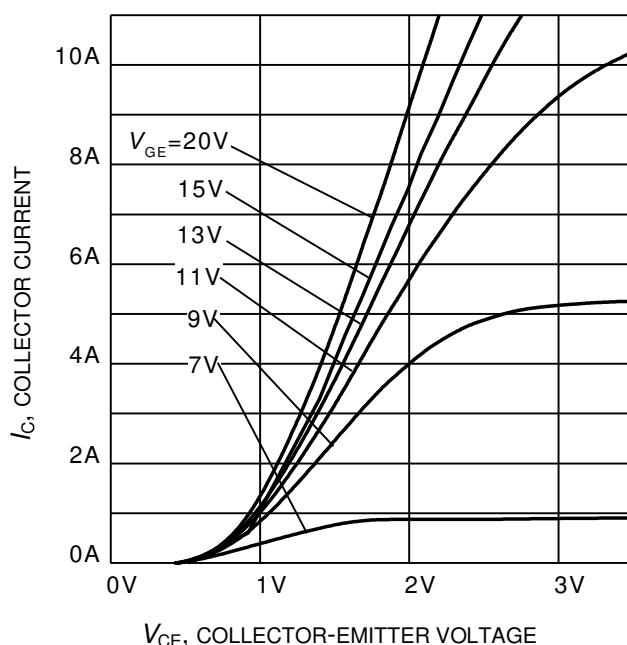
( $D = 0$ ,  $T_C = 25^\circ\text{C}$ ,  $T_j \leq 175^\circ\text{C}$ ;  
 $V_{\text{GE}}=0/15\text{V}$ )



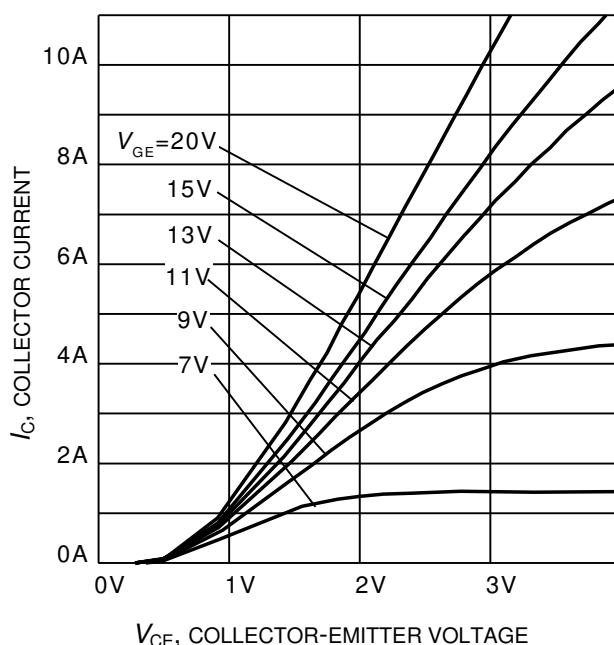
**Figure 3. Power dissipation as a function of case temperature**  
( $T_j \leq 175^\circ\text{C}$ )



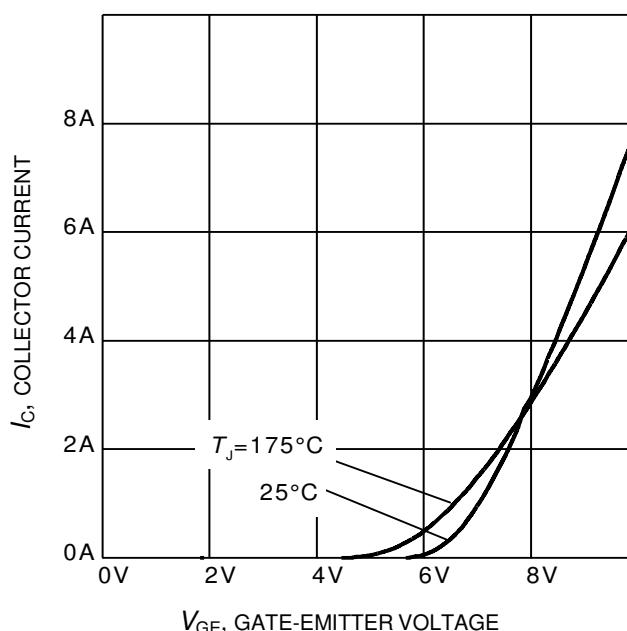
**Figure 4. Collector current as a function of case temperature**  
( $V_{\text{GE}} \geq 15\text{V}$ ,  $T_j \leq 175^\circ\text{C}$ )



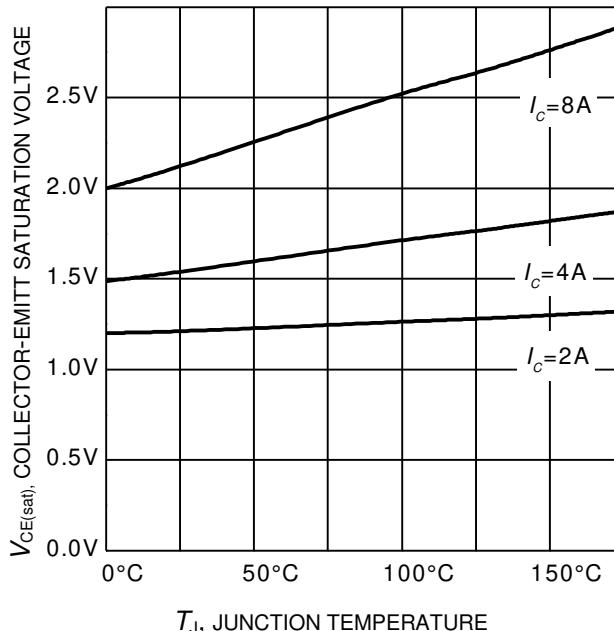
**Figure 5. Typical output characteristic**  
( $T_j = 25^\circ\text{C}$ )



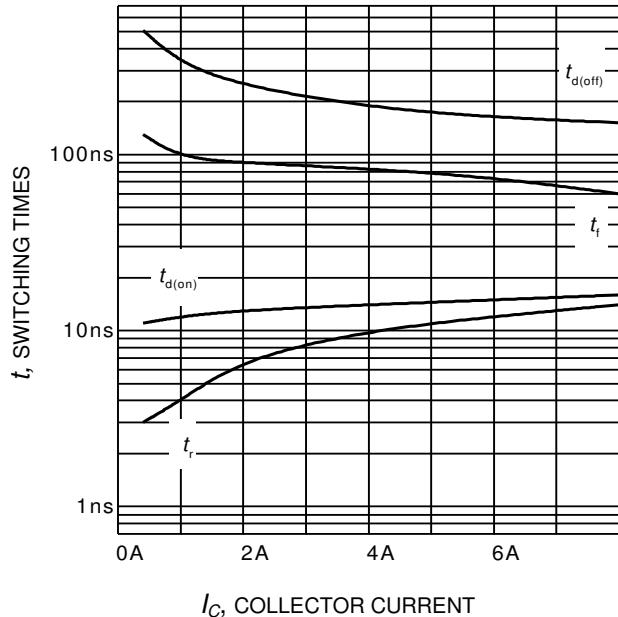
**Figure 6. Typical output characteristic**  
( $T_j = 175^\circ\text{C}$ )



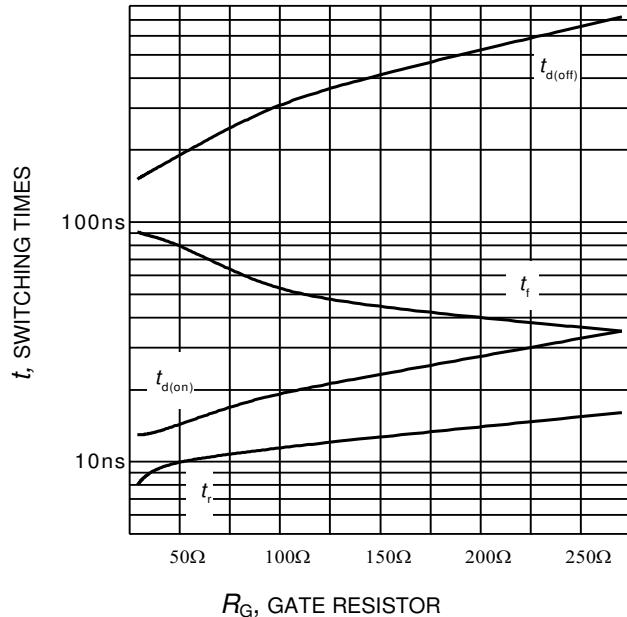
**Figure 7. Typical transfer characteristic**  
( $V_{CE}=20\text{V}$ )



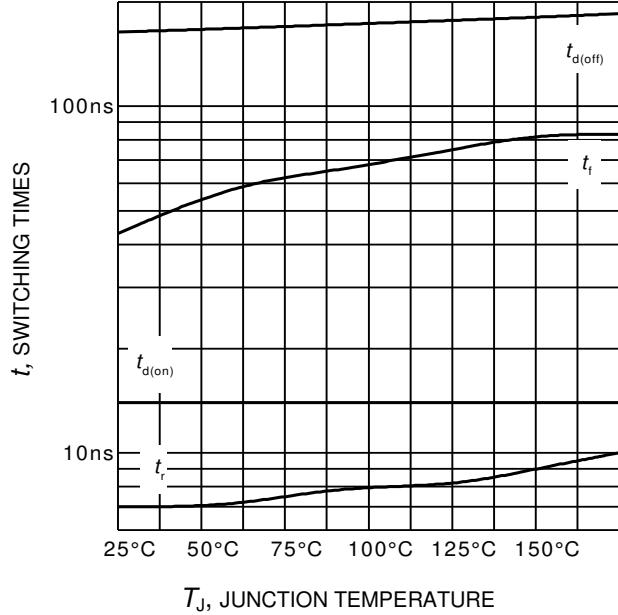
**Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature**  
( $V_{GE} = 15\text{V}$ )



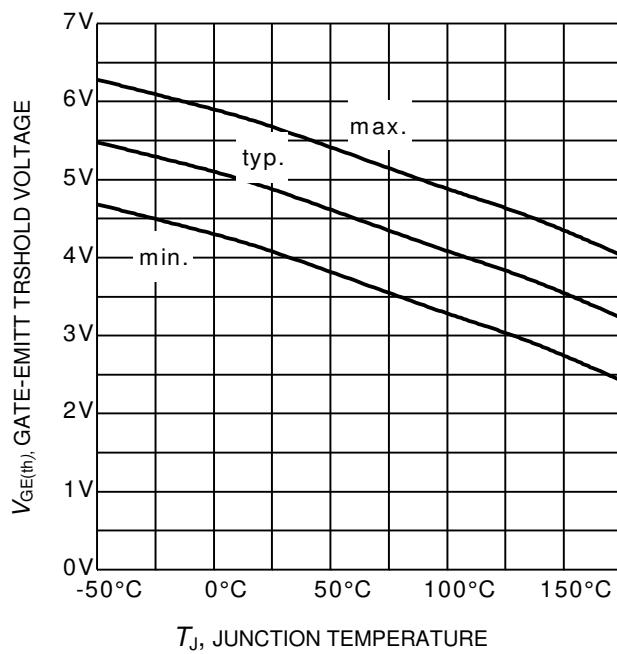
**Figure 9. Typical switching times as a function of collector current**  
 (inductive load,  $T_J=175^\circ\text{C}$ ,  
 $V_{CE}=400\text{V}$ ,  $V_{GE}=0/15\text{V}$ ,  $r_G=47\Omega$ ,  
 Dynamic test circuit in Figure E)



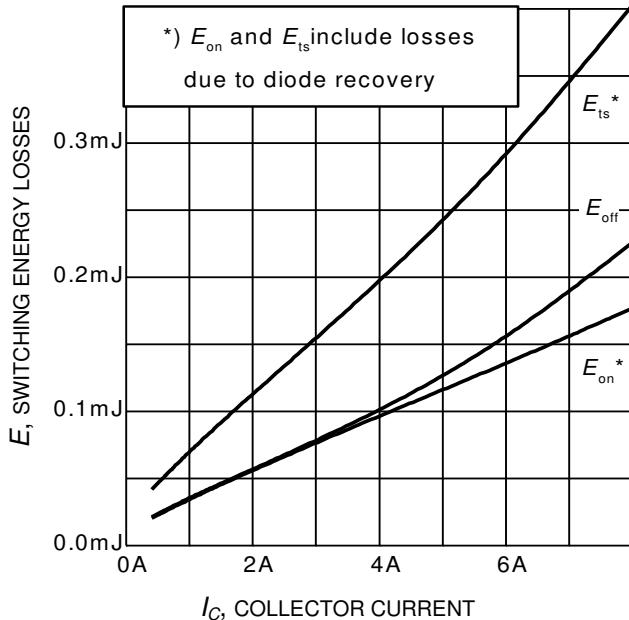
**Figure 10. Typical switching times as a function of gate resistor**  
 (inductive load,  $T_J=175^\circ\text{C}$ ,  
 $V_{CE}=400\text{V}$ ,  $V_{GE}=0/15\text{V}$ ,  $I_C=4\text{A}$ ,  
 Dynamic test circuit in Figure E)



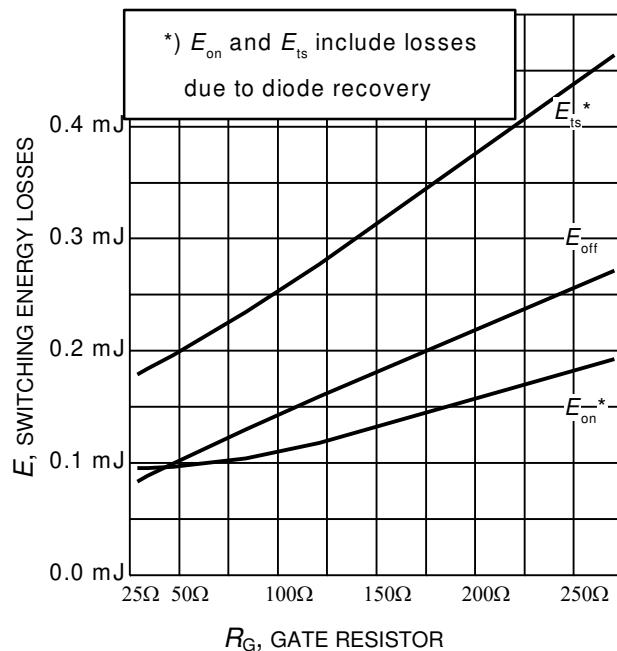
**Figure 11. Typical switching times as a function of junction temperature**  
 (inductive load,  $V_{CE}=400\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $I_C=4\text{A}$ ,  $r_G=47\Omega$ ,  
 Dynamic test circuit in Figure E)



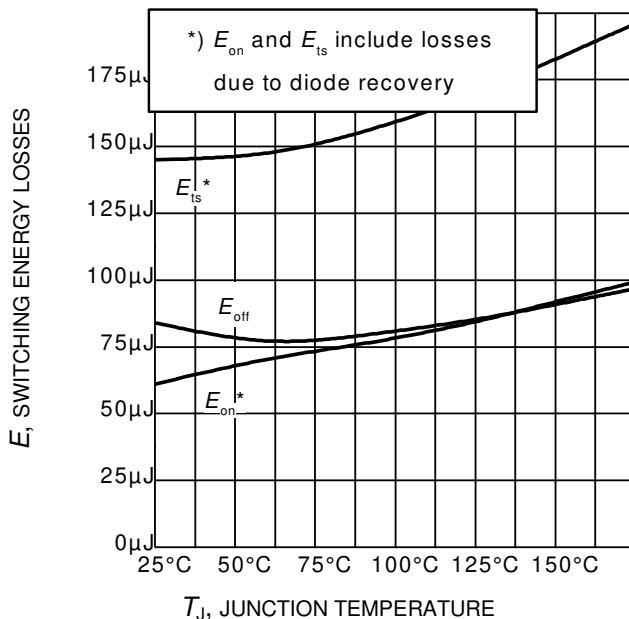
**Figure 12. Gate-emitter threshold voltage as a function of junction temperature**  
 $(I_C = 60 \mu\text{A})$



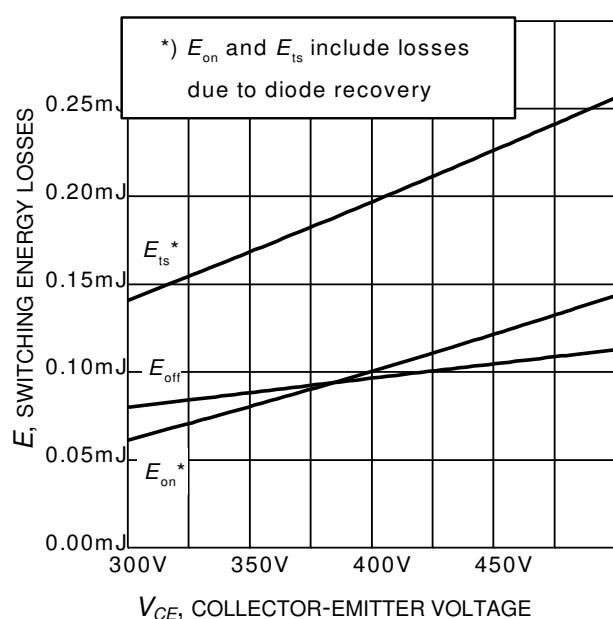
**Figure 13. Typical switching energy losses as a function of collector current**  
(inductive load,  $T_J = 175^\circ\text{C}$ ,  
 $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $r_G = 47\Omega$ ,  
Dynamic test circuit in Figure E)



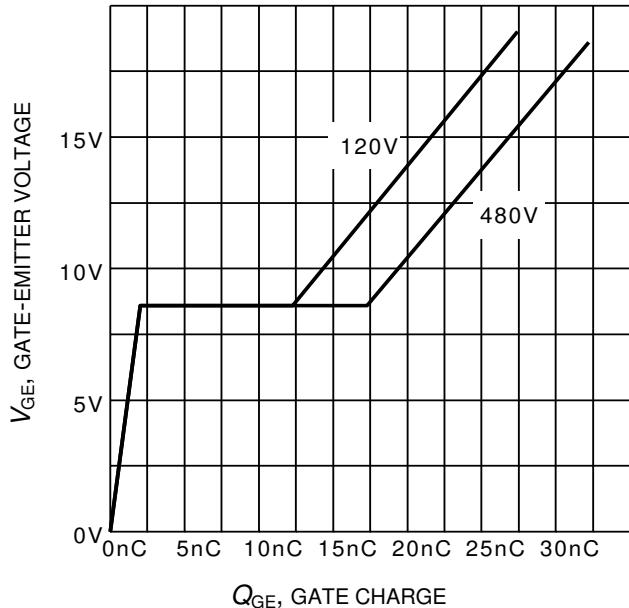
**Figure 14. Typical switching energy losses as a function of gate resistor**  
(inductive load,  $T_J = 175^\circ\text{C}$ ,  
 $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $I_C = 4\text{A}$ ,  
Dynamic test circuit in Figure E)

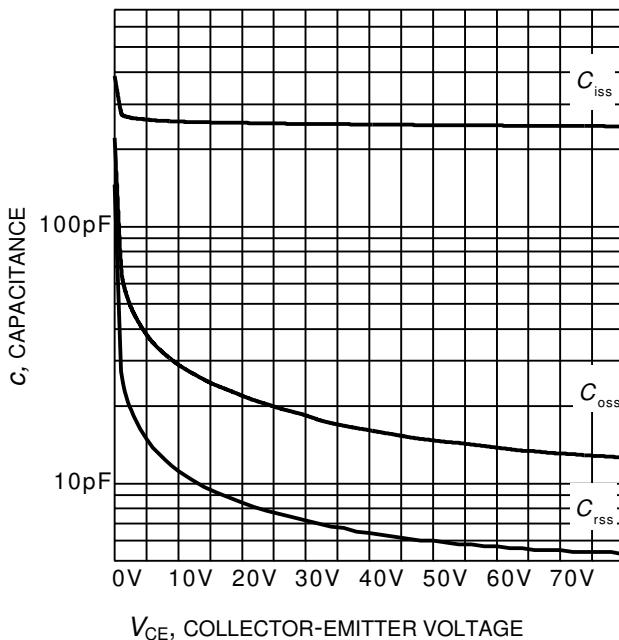


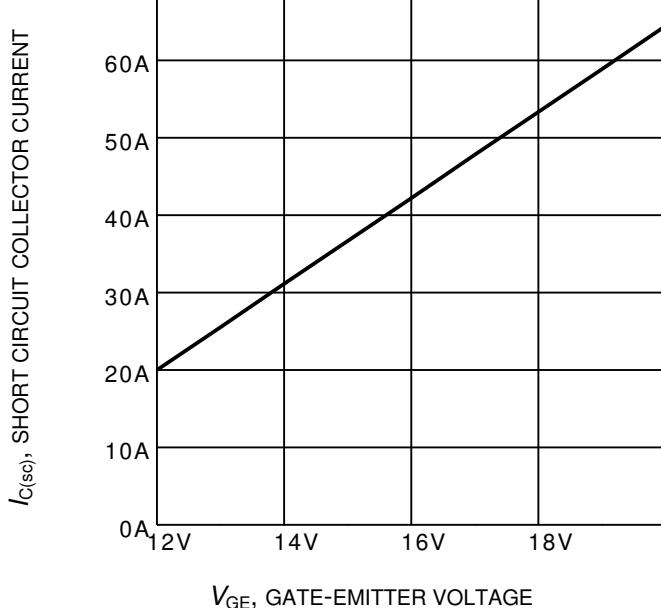
**Figure 15. Typical switching energy losses as a function of junction temperature**  
(inductive load,  $V_{CE} = 400\text{V}$ ,  
 $V_{GE} = 0/15\text{V}$ ,  $I_C = 4\text{A}$ ,  $r_G = 47\Omega$ ,  
Dynamic test circuit in Figure E)

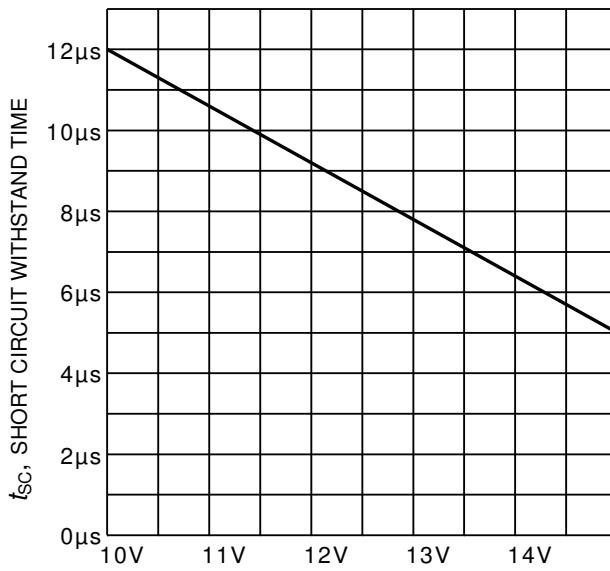


**Figure 16. Typical switching energy losses as a function of collector-emitter voltage**  
(inductive load,  $T_J = 175^\circ\text{C}$ ,  
 $V_{GE} = 0/15\text{V}$ ,  $I_C = 4\text{A}$ ,  $r_G = 47\Omega$ ,  
Dynamic test circuit in Figure E)

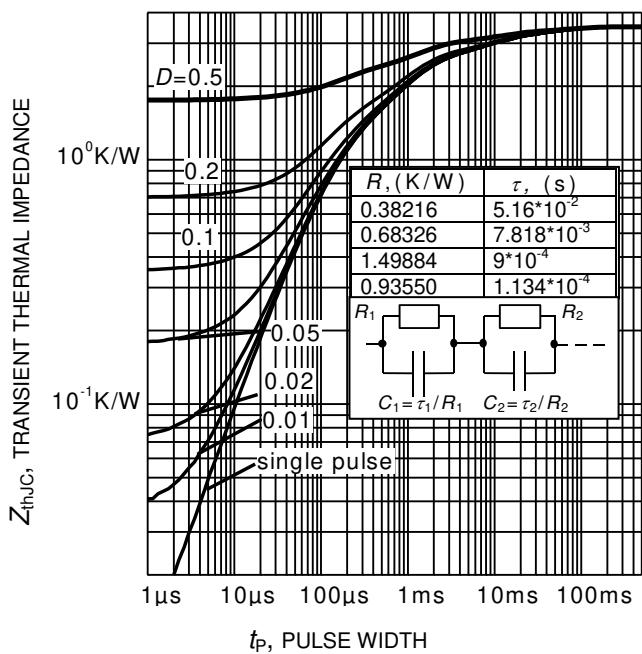

 $Q_{GE}$ , GATE CHARGE

**Figure 17. Typical gate charge**  
 $(I_C=4\text{ A})$ 

 $V_{CE}$ , COLLECTOR-EMITTER VOLTAGE

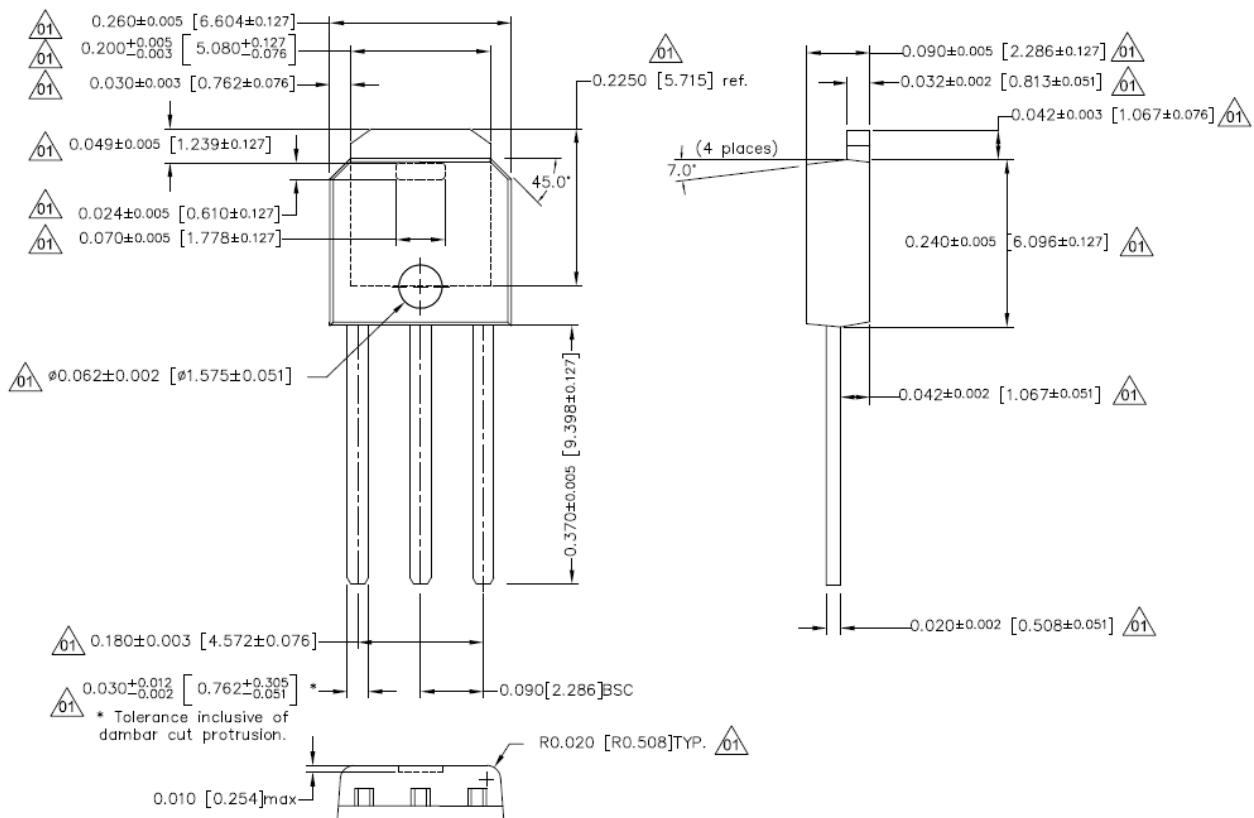
**Figure 18. Typical capacitance as a function of collector-emitter voltage**  
 $(V_{GE}=0\text{V}, f=1\text{ MHz})$ 

 $V_{GE}$ , GATE-EMITTER VOLTAGE

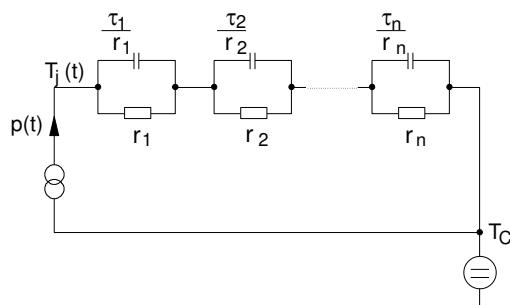
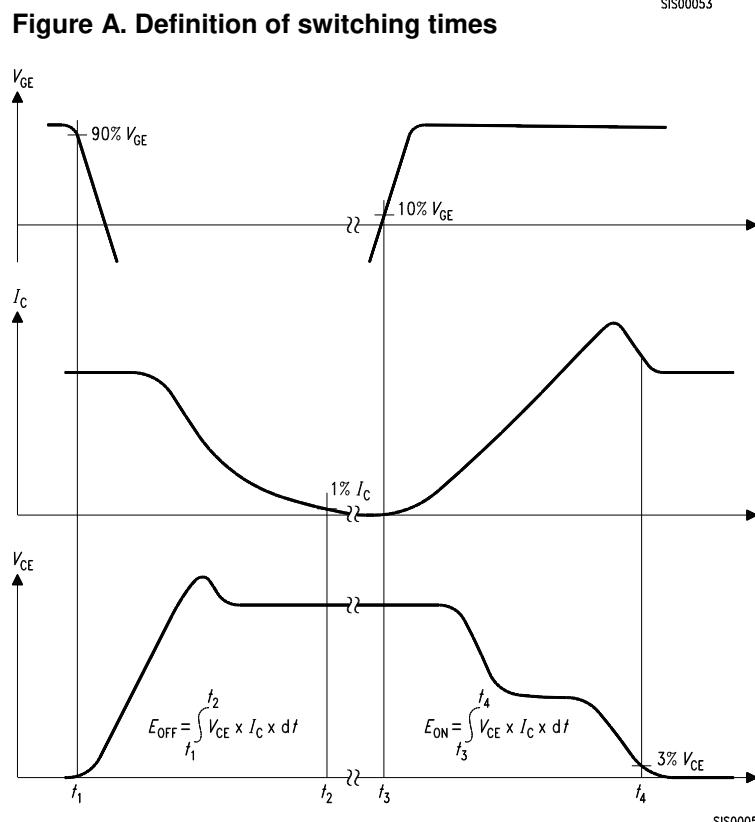
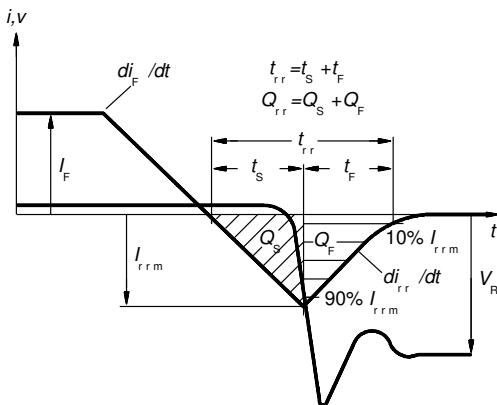
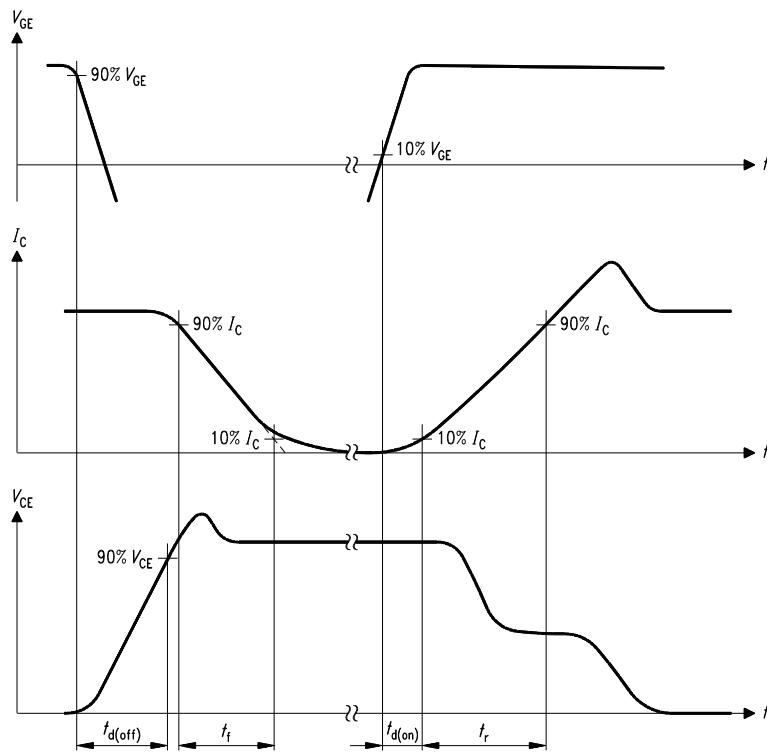
**Figure 19. Typical short circuit collector current as a function of gate-emitter voltage**  
 $(V_{CE} \leq 400\text{V}, T_j \leq 150^\circ\text{C})$ 

 $V_{GE}$ , GATE-EMITTER VOLTAGE

**Figure 20. Short circuit withstand time as a function of gate-emitter voltage**  
 $(V_{CE}=400\text{V}, \text{start at } T_j=25^\circ\text{C}, T_{j,\max}<150^\circ\text{C})$

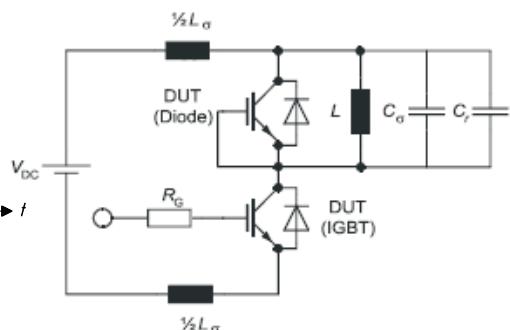


**Figure 21. IGBT transient thermal impedance**  
 $(D = t_p / T)$

**PG-T0251-3**




**Figure D. Thermal equivalent circuit**



**Figure E. Dynamic test circuit**  
 Parasitic inductance  $L_\alpha$ ,  
 Parasitic capacitor  $C_\alpha$ ,  
 Relief capacitor  $C_r$   
 (only for ZVT switching)

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